Se	arch	Notes	

Application/Control No.	Applicant(s)/Patent un Reexamination	der
10/830,167	EHMIG ET AL.	
Examiner	Art Unit	
John A. Radi	3641	

SEARCHED				
Class	Subclass	Date	Examiner	
227	10, 135, 136, 9, 8			
89	33.14			
	33.2			
	33.1			
102	531, 204			
	281, 530	2/14/2006	JAR	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,		
	<u> </u>			

DATE	
DATE	EXMR
2/14/2006	JAR
	2/14/2006